

<b>Notice of References Cited</b>	Application/Control No. 10/622,029	Applicant(s)/Patent Under Reexamination TAKIZAWA ET AL.	
	Examiner Quoc A. Tran	Art Unit 2176	Page 1 of 1

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	B	US-2003/0120686 A1	06-2003	Kim et al.	707/200
	C	US-6,209,124 B1	03-2001	Vermeire et al.	717/114
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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